

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/625,893	PHU, THINH NGUYEN	
Examiner Meless N. Zewdu		Art Unit 2617	Page 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0137848 A1	07-2003	Chang et al.	362/418
*	B	US-7,151,941 B2	12-2006	Vanttinen et al.	455/456.2
*	C	US-7,154,903 B2	12-2006	Sivalingham, Sanjeevan	370/429
*	D	US-2002/0057658 A1	05-2002	Lim, Byung Keun	370/331
*	E	US-6,584,314 B1	06-2003	Haumont et al.	455/435.1
*	F	US-7,003,294 B2	02-2006	Singhai et al.	455/435.1
*	G	US-2005/0239476 A1	10-2005	Betrabet et al.	455/456.1
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 02/082824 A2	10-2002	PCT	Turinà et al.	H04Q 7/20
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.